

RoHS Compliant Product
A suffix of "-C" specifies halogen & lead-free

DESCRIPTION

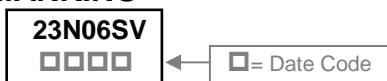
The SSG23N06SV-C is the Shielded Gate Technology N-Ch MOSFETs with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

The SSG23N06SV-C meet the RoHS and Green Product requirement with full function reliability approved.

FEATURES

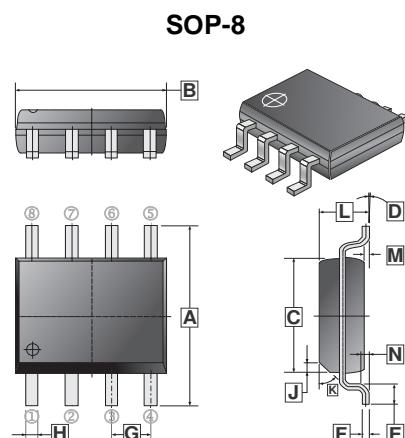
- Shielded Gate Trench Technology
- Super Low Gate Charge
- Green Device Available

MARKING

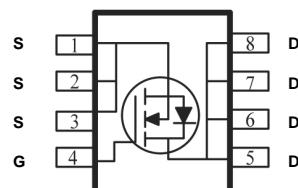


PACKAGE INFORMATION

Package	MPQ	Leader Size
SOP-8	2.5K	13' inch



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	5.79	6.20	H	0.33	0.51
B	4.70	5.11	J	0.375	REF.
C	3.80	4.00	K	45	REF.
D	0°	8°	L	1.3	1.752
E	0.40	1.27	M	0	0.25
F	0.10	0.25	N	0.25	REF.
G	1.27 TYP.				



ORDER INFORMATION

Part Number	Type
SSG23N06SV-C	Lead (Pb)-free and Halogen-free

ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ¹ @ $V_{GS}=10\text{V}$	I_D	23	A
		18	
Pulsed Drain Current ^{2,3}	I_{DM}	60	A
Power Dissipation ²	P_D	3.1	W
Operating Junction & Storage Temperature Range	T_J, T_{STG}	-55~150	°C
Thermal Resistance Ratings			
Thermal Resistance Junction-ambient ¹	$R_{\theta JA}$	$t \leq 10\text{s}, 40$	°C/W
		Steady State, 75	
Thermal Resistance Junction-Case ¹	$R_{\theta JC}$	24	

ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Drain-Source Breakdown Voltage	BV_{DSS}	60	-	-	V	$\text{V}_{GS}=0\text{V}$, $I_D=250\mu\text{A}$
Gate-Threshold Voltage	$\text{V}_{GS(\text{th})}$	2	-	4	V	$\text{V}_{DS}=\text{V}_{GS}$, $I_D=250\mu\text{A}$
Forward Transfer conductance	g_{fs}	-	65	-	S	$\text{V}_{DS}=5\text{V}$, $I_D=10\text{A}$
Gate-Source Leakage Current	I_{GS}	-	-	± 100	nA	$\text{V}_{GS}= \pm 20\text{V}$
Drain-Source Leakage Current	I_{DSS}	-	-	1	μA	$\text{V}_{DS}=48\text{V}$, $\text{V}_{GS}=0\text{V}$
		-	-	5		$\text{V}_{DS}=48\text{V}$, $\text{V}_{GS}=0\text{V}$
Static Drain-Source On-Resistance ³	$R_{DS(\text{ON})}$	-	3.2	3.8	$\text{m}\Omega$	$\text{V}_{GS}=10\text{V}$, $I_D=10\text{A}$
		-	3.9	5.2		$\text{V}_{GS}=7\text{V}$, $I_D=5\text{A}$
Total Gate Charge	Q_g	-	59	-	nC	$I_D=10\text{A}$ $\text{V}_{DS}=30\text{V}$ $\text{V}_{GS}=10\text{V}$
Gate-Source Charge	Q_{gs}	-	15	-		
Gate-Drain ("Miller") Charge	Q_{gd}	-	10	-		
Turn-On Delay Time	$T_{d(on)}$	-	20	-	nS	$\text{V}_{DD}=30\text{V}$ $I_D=10\text{A}$ $\text{V}_{GS}=10\text{V}$ $R_G=3\Omega$
Rise Time	T_r	-	9	-		
Turn-Off Delay Time	$T_{d(off)}$	-	60	-		
Fall Time	T_f	-	15	-		
Input Capacitance	C_{iss}	-	3509	-	pF	$\text{V}_{GS}=0\text{V}$ $\text{V}_{DS}=30\text{V}$ $f=1\text{MHz}$
Output Capacitance	C_{oss}	-	1175	-		
Reverse Transfer Capacitance	C_{rss}	-	68	-		
Source-Drain Diode						
Diode Forward Voltage ³	V_{SD}	-	-	1.2	V	$I_s=1\text{A}$, $\text{V}_{GS}=0\text{V}$
Continuous Source Current ¹	I_s	-	-	23	A	
Pulsed Source Current ^{2 3}	I_{SM}	-	-	60	A	
Reverse Recovery Time	T_{rr}	-	24	-	nS	$I_F=10\text{A}$, $dI/dt=100\text{A}/\mu\text{s}$, $T_J=25^\circ\text{C}$
Reverse Recovery Charge	Q_{rr}	-	85	-	nC	

Notes:

- The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- The power dissipation is limited by 150°C junction temperature.
- The data tested by pulsed, pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$.

CHARACTERISTICS CURVE

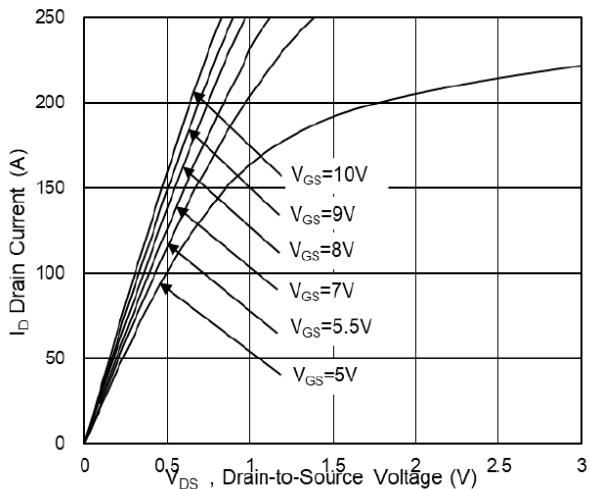


Fig.1 Typical Output Characteristics

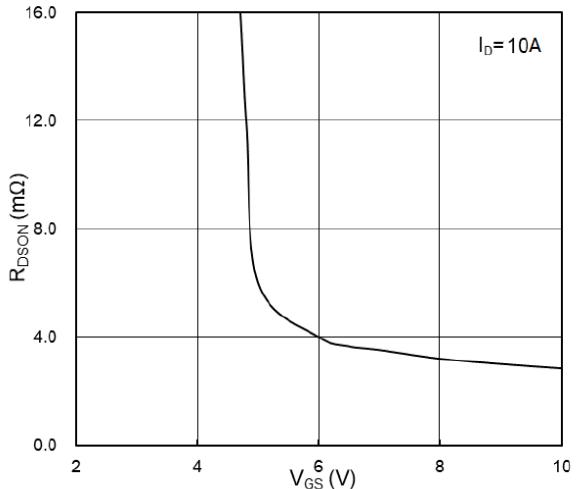


Fig.2 On-Resistance vs G-S Voltage

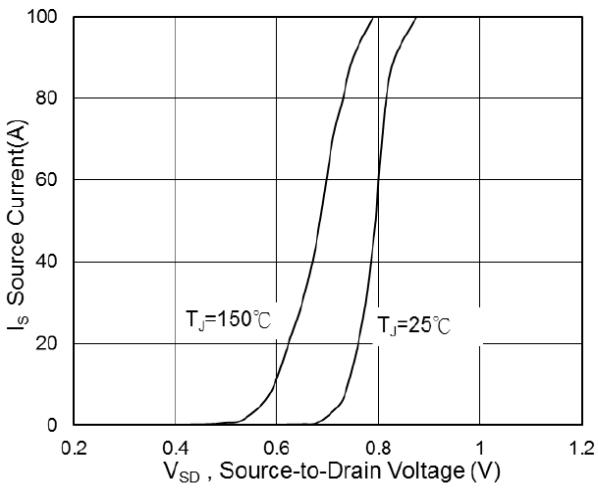


Fig.3 Diode Forward Voltage vs Current

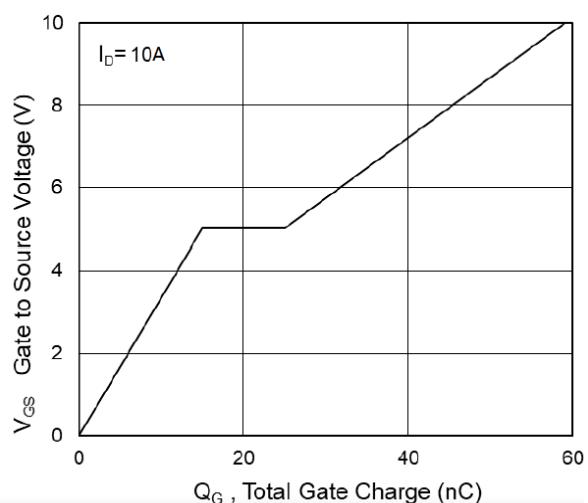


Fig.4 Gate-Charge Characteristics

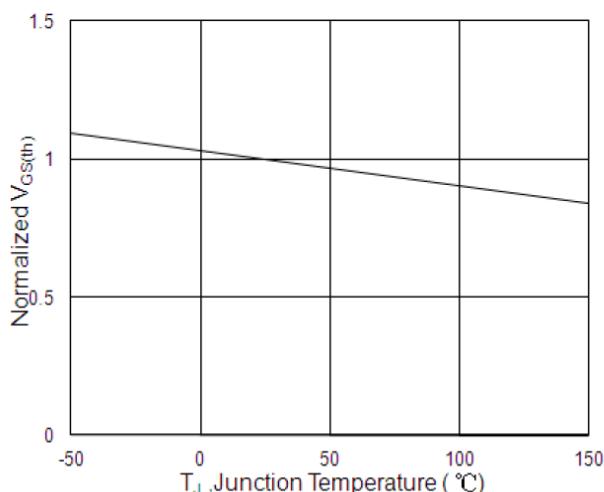


Fig.5 Normalized $V_{GS(th)}$ vs T_J

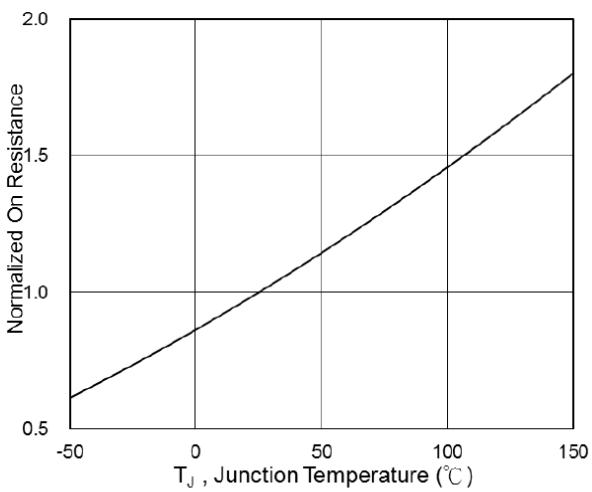


Fig.6 Normalized $R_{DS(on)}$ vs T_J

CHARACTERISTICS CURVE

